

Search Notes

Application/Control No.

10/616,479

Examiner

Tae H. Yoon

Applicant(s)/Patent under
Reexamination

MCCLESKEY ET AL.

Art Unit

1714

SEARCHED

Class	Subclass	Date	Examiner
106	436	5/21/07	z
528	490		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
CAST Zaunert Search	5/21/07	z